

30V P-Channel Enhancement Mode MOSFET**Description**

The PECN9P03QR uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in load switch and battery protection applications.

General Features

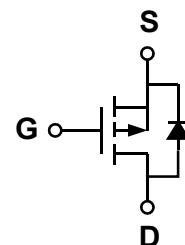
- ◆ $V_{DS} = -30V$, $I_D = -9.0A$
 $R_{DS(ON)}(\text{Typ.}) = 23.2m\Omega$ @ $V_{GS} = -4.5V$
 $R_{DS(ON)}(\text{Typ.}) = 18.3m\Omega$ @ $V_{GS} = -10V$
- ◆ High power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface mount package

Application

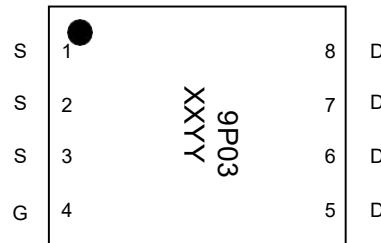
- ◆ Battery protection
- ◆ Load switch

Package

- ◆ PDFN3×3-8L

**Schematic diagram****Marking and pin assignment**

PDFN3×3-8L
(Top View)

**Ordering Information**

Part Number	Storage Temperature	Package	Devices Per Reel
PECN9P03Q R-G	-55°C to +150°C	PDFN3×3-8L	5000

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	V_{DS}	-30	V
Gate-source voltage	V_{GS}	± 20	V
Drain current-continuous ^a @Tj=125°C -pulse d ^b	I_D	-9.0	A
	I_{DM}	-40	A
Drain-source Diode forward current	I_S	-2.5	A
Maximum power dissipation	P_D	35	W
Operating junction Temperature range	Tj	-55—150	°C

Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =-250μA	-30	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V	-	-	-1	μA
Gate-body leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
ON Characteristics						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-1.00	-1.6	-3.0	V
Drain-source on-state resistance	R _{DS(ON)}	V _{GS} =10V, I _D =4.5A	-	18.3	22	mΩ
		V _{GS} =4.5V, I _D =4.5A		23.2	34	
Forward transconductance	g _{fs}	V _{GS} =-5V, I _D =-9A	-	24	-	S
Dynamic Characteristics						
Input capacitance	C _{ISS}	V _{DS} =-15V, V _{GS} =0V f=1.0MHz	-	1040	1250	pF
Output capacitance	C _{OSS}		-	180	-	
Reverse transfer capacitance	C _{RSS}		-	125	175	
Switching Characteristics						
Turn-on delay time	t _{D(ON)}	V _{DS} =-15V R _L =2.2 Ω V _{GS} =-10V R _{GEN} =3 Ω	-	10	-	ns
Rise time	tr		-	5.5	-	
Turn-off delay time	t _{D(OFF)}		-	26	-	
Fall time	tf		-	9	-	
Total gate charge	Q _g (10V)	V _{DS} =-15V, I _D =-9A V _{GS} =-10V	-	19	-	nC
Total gate charge	Q _g (4.5V)			9.6		
Gate-source charge	Q _{gs}		-	3.6	-	
Gate-drain charge	Q _{gd}		-	4.6	-	
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode forward voltage	V _{SD}	V _{GS} =0V, I _s =-1.0A	-	-0.75	-1.0	V

Notes:

- The value of R_{th JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with TA =25°C. The value in any given application depends on the user's specific board design.
- The power dissipation P_D is based on T_{J(MAX)}=150°C, using ≤ 10s junction-to-ambient thermal resistance.
- Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and duty cycles to keep initial T_J=25°C.
- The R_{th JA} is the sum of the thermal impedance from junction to lead R_{th JL} and lead to ambient.
- The static characteristics in Figures 1 to 6 are obtained using <300us pulses, duty cycle 0.5% max.
- These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

Thermal Characteristics

Thermal Resistance junction-to ambient	R _{th} JA	3.57	°C/W
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Typical Performance Characteristics

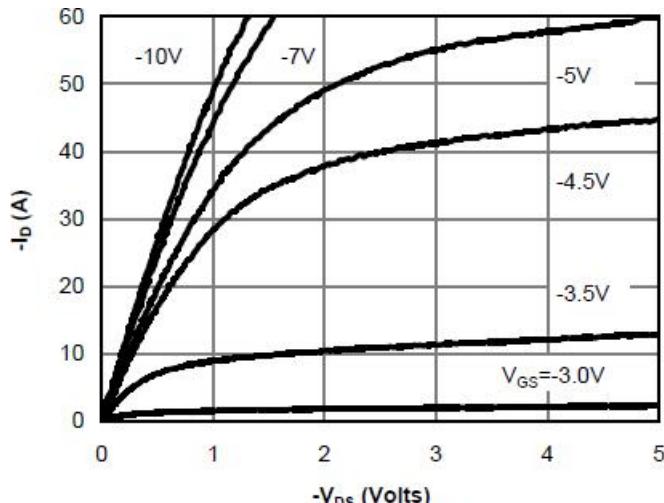


Fig 1: On-Region Characteristics (Note E)

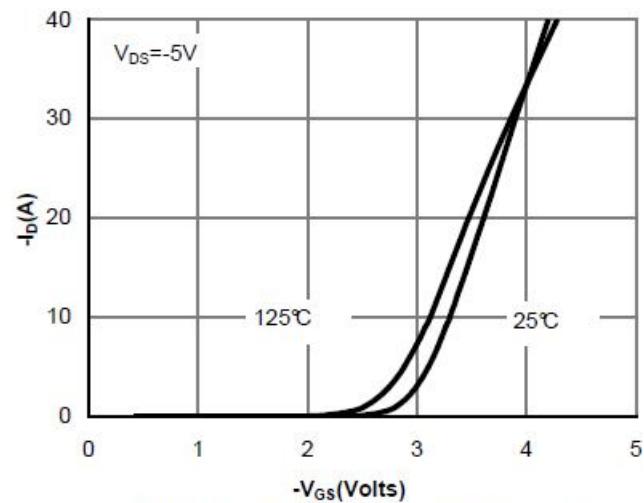


Figure 2: Transfer Characteristics (Note E)

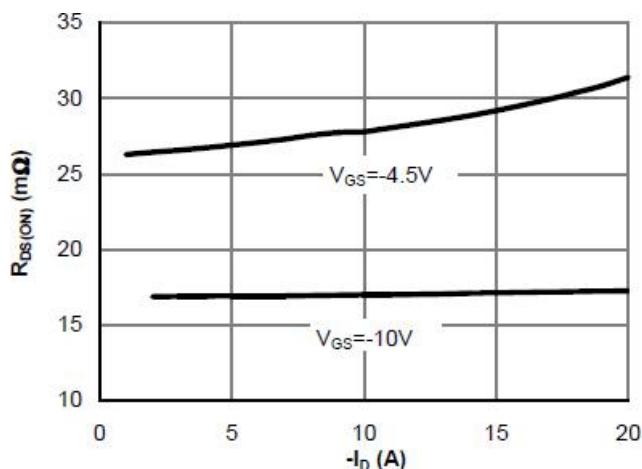


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

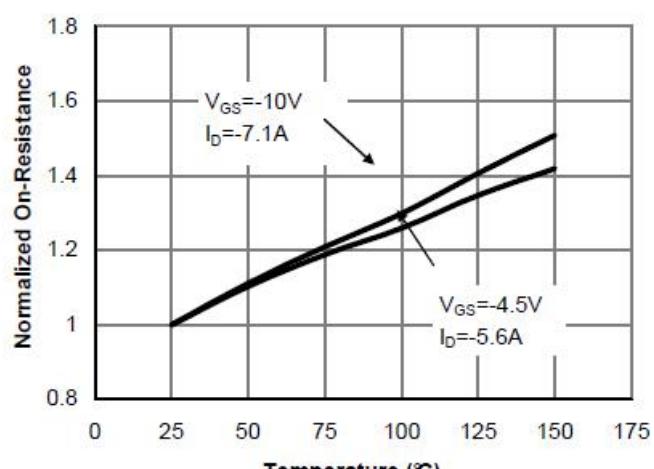


Figure 4: On-Resistance vs. Junction Temperature (Note E)

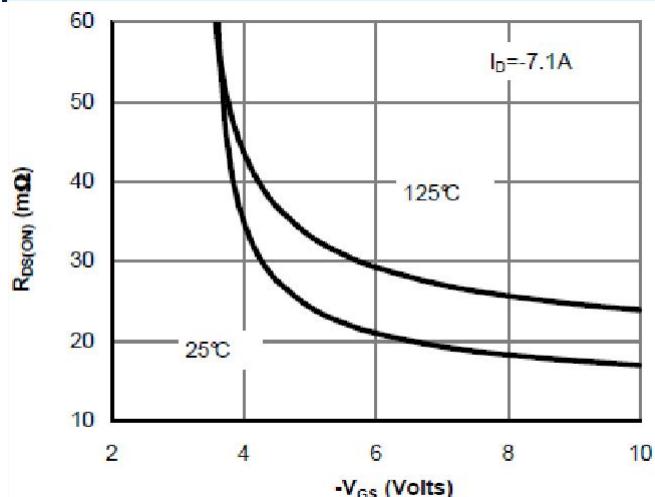


Figure 5: On-Resistance vs. Gate-Source Voltage

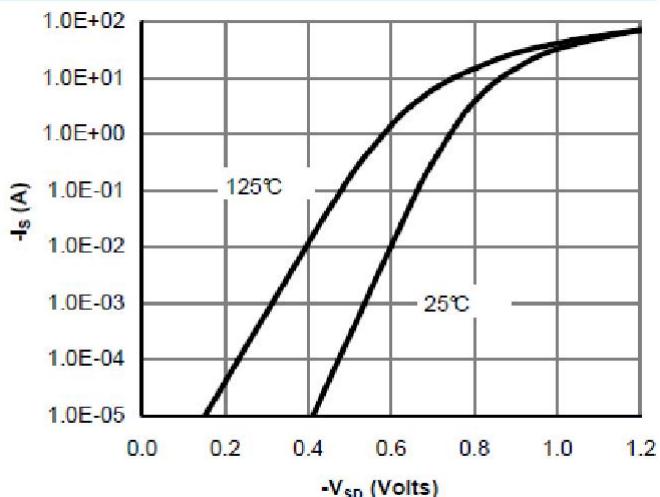


Figure 6: Body-Diode Characteristics (Note E)

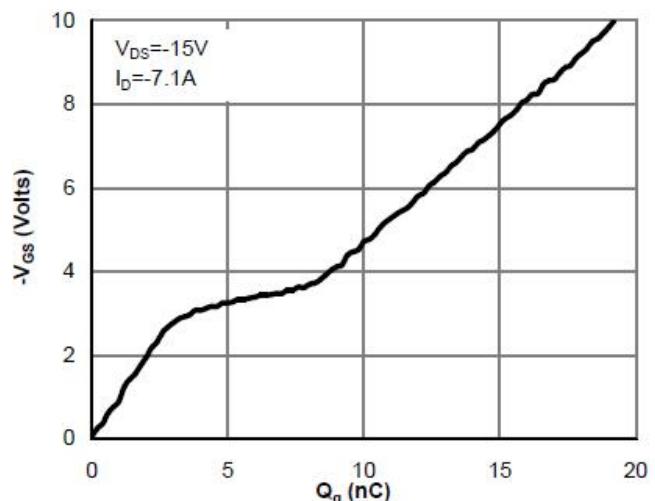


Figure 7: Gate-Charge Characteristics

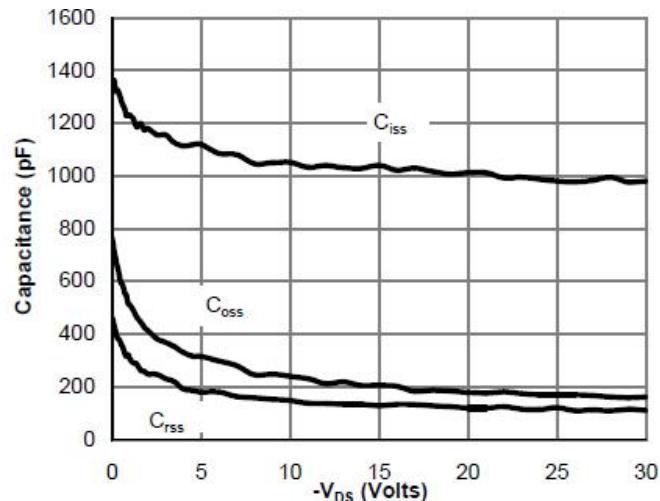


Figure 8: Capacitance Characteristics

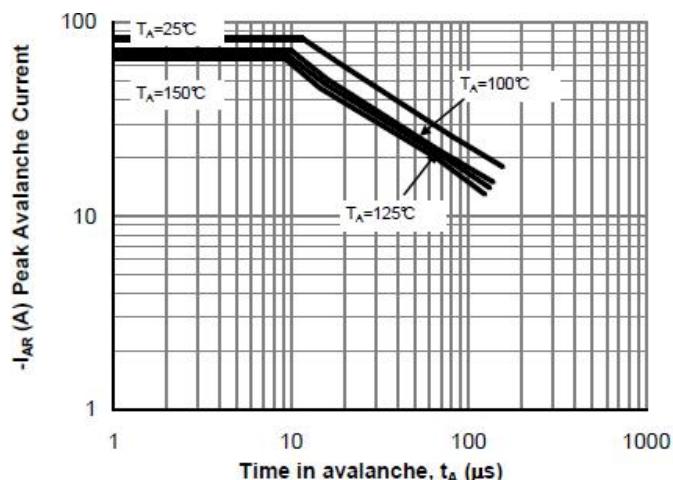


Figure 9: Single Pulse Avalanche capability (Note C)

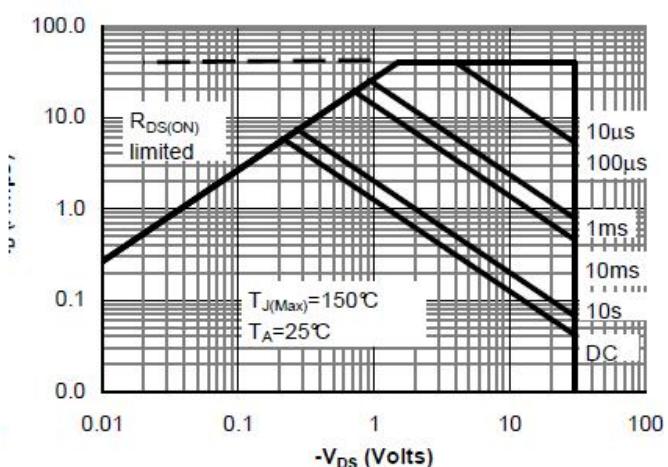


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

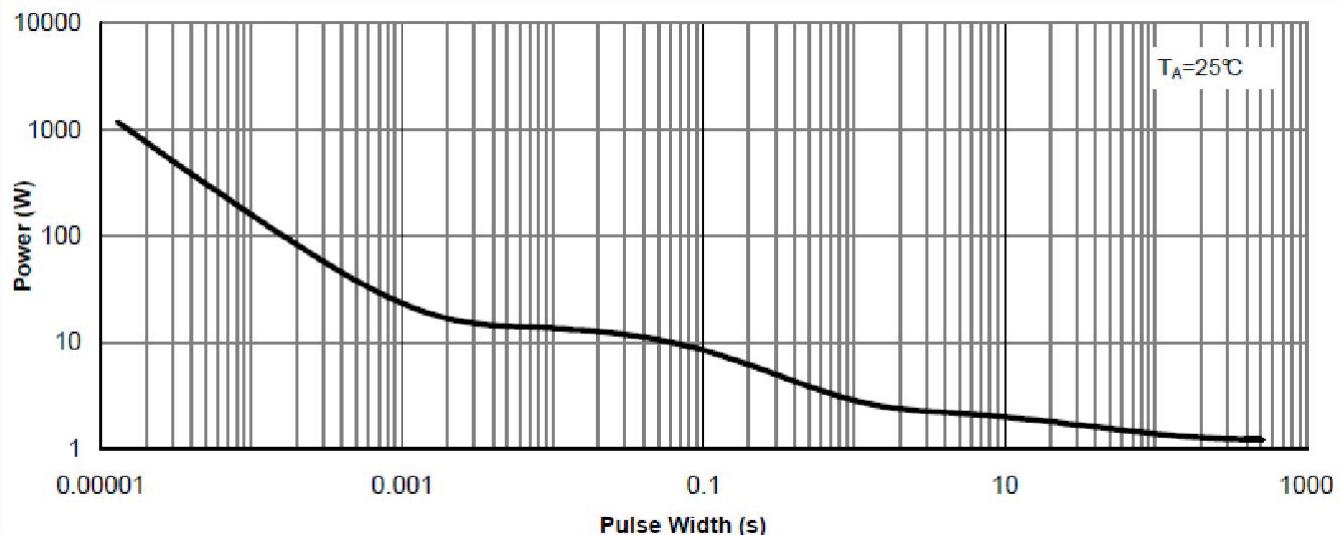


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note F)

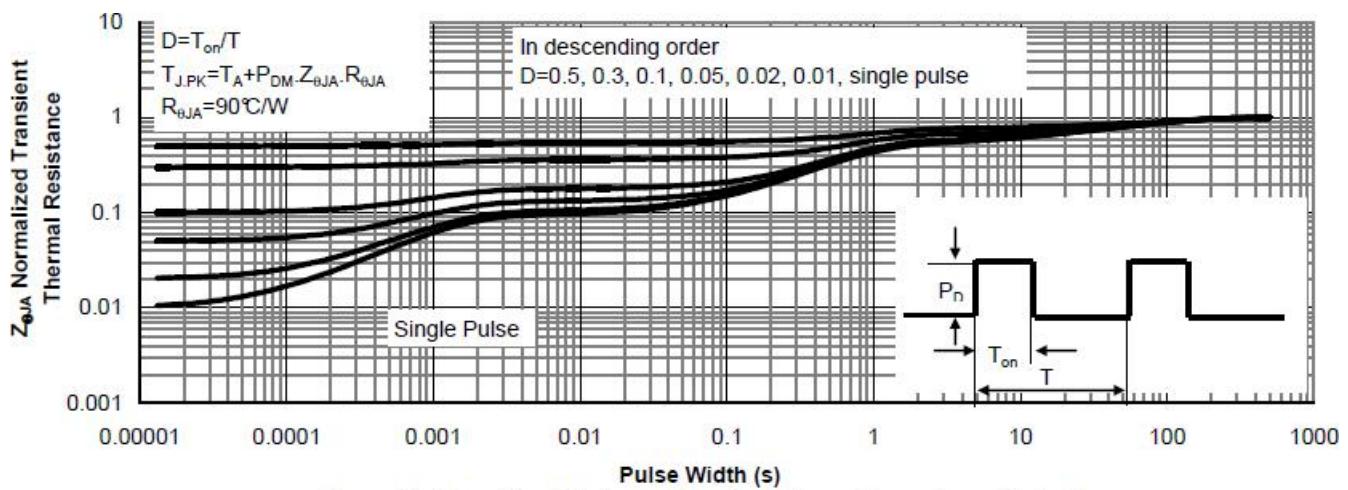
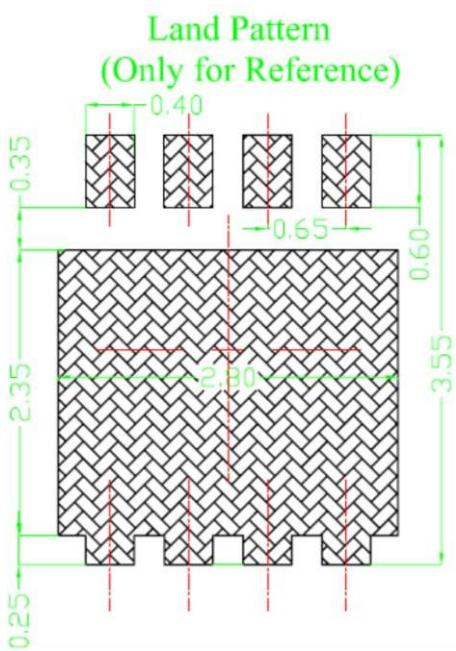
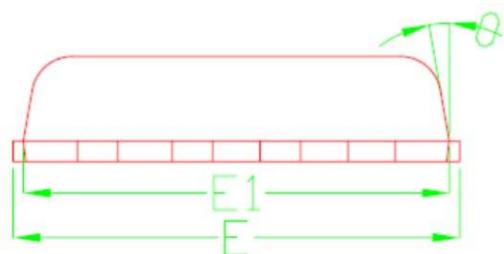
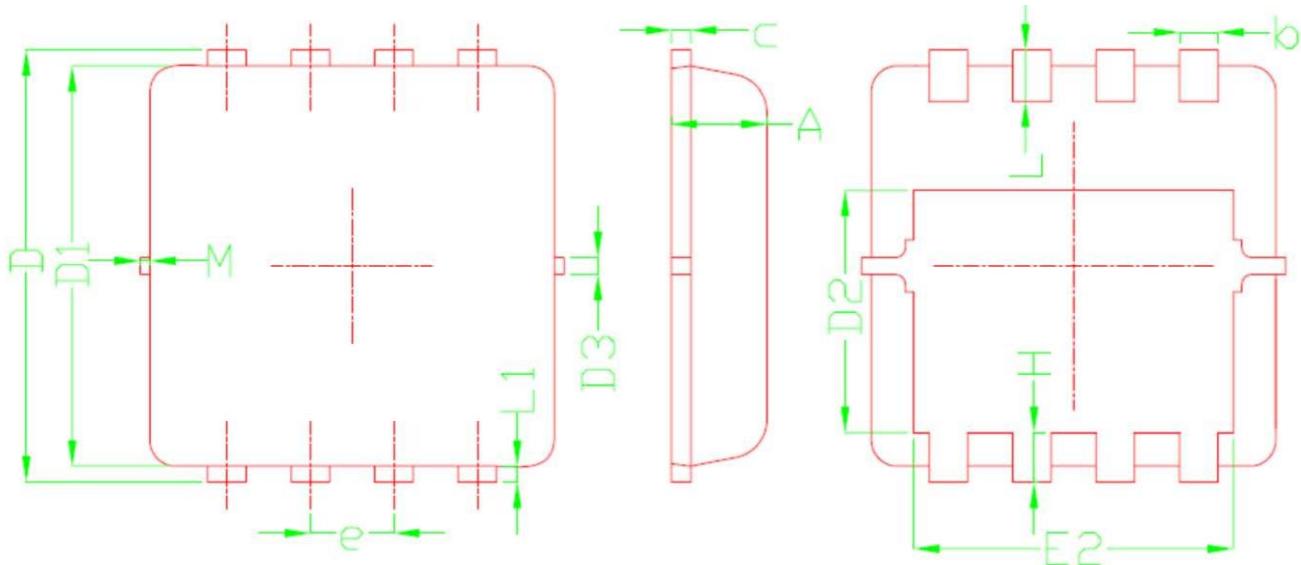


Figure 12: Normalized Maximum Transient Thermal Impedance (Note F)

Package Information

- PDFN3×3-8L



SYMBOL	DIMENSIONAL REQMTS		
	MIN	NOM	MAX
A	0.70	0.75	0.80
b	0.25	0.30	0.35
c	0.10	0.15	0.25
D	3.25	3.35	3.45
D1	3.00	3.10	3.20
D2	1.78	1.88	1.98
D3	---	0.13	---
E	3.20	3.30	3.40
E1	3.00	3.15	3.20
E2	2.39	2.49	2.59
e	0.65BSC		
H	0.30	0.39	0.50
L	0.30	0.40	0.50
L1	---	0.13	---
θ	---	10°	12°
M	*	*	0.15
* Not specified			